

#9

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI40-325		SERIAL NO.		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.				
				FILING DATE Filed Herewith		GROUP 2635		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
EA	AA	3,299,424	01/67	Vinding				
	AB	3,852,755	12/74	Works et al.				
	AC	4,075,632	02/78	Baldwin et al.				
	AD	4,572,976	02/86	Fockens				
	AE	4,656,463	04/87	Anders et al.				
	AF	4,700,179	10/87	Fancher				
	AG	4,724,427	02/88	Carroll				
	AH	4,743,864	05/88	Nakagawa et al.				
EA	AI	4,800,543	01/89	Lyndon-James et al.				
	AJ							
	AK							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
SR	AR		"Micron Morning Report", The Idaho Statesman, July 16, 1993.					
EA	AS		"A Low-Power Spread Spectrum CMOS RFIC for Radio Identification Applications", by John R. Tuttle, Conference Proceedings from RF Expo West, pp. 216-222, March 22-24, 1994, San Jose, CA.					
EA	AT		Provisional Application, Serial No. 60/023,321, Filed July 30, 1996.					
EXAMINER				DATE CONSIDERED				
gmc [Signature]				3-19-04				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI40-325	SERIAL NO. 09/9225163			
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.				
				FILING DATE Filed Herewith	GROUP 2635			
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
ERR	AA	4,816,839	03/89	Landt				
	AB	4,827,395	05/89	Anders et al.				
	AC	4,853,705	08/89	Landt				
	AD	4,854,328	08/89	Pollack				
	AE	4,857,893	08/89	Carroll				
	AF	4,862,160	08/89	Ekchian et al.				
	AG	4,870,419	09/89	Baldwin et al.				
	AH	4,888,591	12/89	Landt et al.				
	AI	4,890,072	12/89	Espe et al.				
	AJ	4,912,471	03/90	Tyburski et al.				
ERR	AK	4,926,182	05/90	Ohta et al.				
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
ERR	AR		<u>"CMOS Analog Integrated Circuits Based on Weak Inversion Operation"</u> , by Eric Vittoz and Jean Fellrath, IEEE Journal of					
			Solid State Circuits, Vol. SC-12, No. 3, June 1977					
ERR	AS		Mitsubishi Motors Corporation Web Page, 1995					
ERR	AT		<u>"Digital RF/ID Enhances GPS"</u> , by John R. Tuttle, Proceedings of the Second Annual Wireless Symposium, pp.406-411,					
			February 15-18, 1994, Santa Clara, CA					
EXAMINER ERR				DATE CONSIDERED 8-19-04				
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								

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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.			
				FILING DATE Filed Herewith	GROUP 2635		
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
SEA	AA	5,030,807	07/91	Landt et al.			
	AB	5,075,691	12/91	Garay et al.			
	AC	5,081,458	01/92	Meunier			
	AD	5,086,389	02/92	Hassett et al.			
	AE	5,122,687	06/92	Schmidt			
	AF	5,128,938	07/92	Borras			
	AG	5,130,668	07/92	Emslie et al.			
	AH	5,134,085	07/92	Gilgen et al.			
	AI	5,142,292	08/92	Chang			
	AJ	5,144,314	09/92	Malmberg et al.			
SEA	AK	5,151,624	09/92	Stegherr et al.			
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
SEA	AR		Provisional Application, Serial No. 60/023,318, Filed July 30, 1996.				
SEA	AS		"Micon RFID Communications Protocol Manual," July 22, 1993, Pre-Release Version 0.95, pp. 1-71.				
SEA	AT		Muller & Kamins, DEVICE ELECTRONICS FOR INTEGRATED CIRCUITS, 1977, John Wiley & Sons, 2 nd Edition, Pages 157-160.				
EXAMINER Ed C. Kelly			DATE CONSIDERED 3-19-04				
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M140-325		SERIAL NO. 09/822063		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.				
				FILING DATE Filed Herewith		GROUP 2635		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
SEA	AA	5,153,583	10/92	Murdoch				
	AB	5,164,985	11/92	Nysen et al.				
	AC	5,175,774	12/92	Truax et al.				
	AD	5,206,609	04/93	Mijuskovic				
	AE	5,218,343	06/93	Stobbe et al.				
	AF	5,231,273	07/93	Caswel				
	AG	5,252,979	10/93	Nysen				
	AH	5,272,367	12/93	Dennison et al.				
	AI	5,287,112	02/94	Schuermann				
	AJ	5,294,928	03/94	Cooper et al.				
SEA	AK	5,300,875	04/89	Tuttle				
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
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	AL							
	AM							
	AN							
	AO							
	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
SEA	AR		Fink & Christiansen, ELECTRONICS ENGINEER'S HANDBOOK, 1989, McGraw-Hill Book Company, 3 rd Edition, Pages 7-41 to 7-42, 8-38 to 8-39, and 9-66 to 6-69.					
SEA	AS		Raymond W. Waugh, "Designing Detectors for RFID Tags," Proceedings of RF Expo West, 1995, 13 pages.					
SEA	AT		Paul R. Gray et al., "Analysis and Design of Analog Integrated Circuits," John Wiley & Sons, Inc., 1977, pp. 667-681.					
EXAMINER Eric P. Hall				DATE CONSIDERED 3-19-04				
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M140-325		SERIAL NO. 09822663		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.				
				FILING DATE Filed Herewith		GROUP 2635		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
EA	AA	5,311,186	05/94	Utsu et al.				
	AB	5,323,150	06/94	Tuttle				
	AC	5,355,513	10/94	Clarke et al.				
	AD	5,365,551	11/94	Snodgrass et al.				
	AE	5,374,930	12/94	Schuermann				
	AF	5,394,444	02/95	Silvey et al.				
	AG	5,406,263	04/95	Tuttle				
	AH	5,412,351	05/95	Nystrom et al.				
	AI	5,420,757	05/95	Eberhardt et al.				
	AJ	5,430,441	07/95	Bickley et al.				
EA	AK	5,444,223	08/95	Blama				
FOREIGN PATENT DOCUMENTS								
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	AL							
	AM							
	AN							
	AO							
	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
EA	AR		Donald O. Pederson, "Analog Integrated Circuits for Communication, Principles, Simulation and Design," Kluwer Academic Publishers,					
			1991, pp. 431-433.					
SA	AS		Barrie Gilbert, "A Precise Four-Quadrant Multiplier with Subnanosecond Response," IEEE Journal of Solid-State Circuits, 1968,					
			pp. 365-373.					
	AT							
EXAMINER Ed C. Dolan				DATE CONSIDERED 11-19-04				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.			
				FILING DATE Filed Herewith		GROUP 2635	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
EA	AA	5,446,761	08/95	Nag et al.	/		
	AB	5,448,110	09/95	Tuttle et al.	/		
	AC	5,448,242	09/95	Sharpe et al.	/		
	AD	5,448,772	09/95	Grandfield	/		
	AE	5,450,087	09/95	Hurta et al.	/		
	AF	5,461,385	10/95	Armstrong	/		
	AG	5,471,212	11/95	Sharpe et al.	/		
	AH	5,478,991	12/95	Watanabe et al.	/		
	AI	5,489,546	02/96	Ahmad et al.	/		
	AJ	5,499,214	03/96	Mori et al.	/		
EA	AK	5,500,650	03/96	Snodgrass et al.	/		
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER Edmund A. Holl				DATE CONSIDERED 3-19-04			
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.			
				FILING DATE Filed Herewith	GROUP 2635		
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
EA	AA	5,525,992	Froschermeier	/	/		
	AB	5,541,583	Mandelbaum	/	/		
	AC	5,541,585	Duhame et al.	/	/		
	AD	5,568,512	Rotzoll	/	/		
	AE	5,606,323	Heinrich et al.	/	/		
	AF	5,621,412	Sharpe et al.	/	/		
	AG	5,623,224	Yamada et al.	/	/		
	AH	5,649,296	MacLellan et al.	/	/		
	AI	5,657,359	Sakae et al.	/	/		
	AJ	5,677,667	Lesesky et al.	/	/		
EA	AK	5,686,864	Martin et al.	/	/		
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EXAMINER EA CAJOL				DATE CONSIDERED 3-19-04			
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI40-325		SERIAL NO. 7 09827063	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.			
				FILING DATE Filed Herewith		GROUP 2635	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
SJA	AA	5,686,920	11/97	Hurta et al.	/		
	AB	5,703,509	12/97	Hirata	/		
	AC	5,719,550	02/98	Bloch et al.	/		
	AD	5,721,678	02/98	Widl	/		
	AE	5,721,783	02/98	Anderson	/		
	AF	5,726,630	03/98	Marsh et al.	/		
	AG	5,815,042	09/98	Chow et al.	/		
	AH	5,901,349	05/99	Guegnaud et al.	/		
	AI	4,746,830	05/88	Holland	/		
	AJ	4,786,903	11/88	Grindahl et al.	/		
SJA	AK	4,952,889	08/90	Irwin et al.	/		
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER <i>Edna C. Allen</i>				DATE CONSIDERED 3-19-04			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI40-325		SERIAL NO. 07822063	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.		GROUP 2635	
				FILING DATE Filed Herewith			
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
<div style="font-size: 2em; font-family: cursive;">S</div>	AA	5,191,295	03/93	Necoechea	/		
	AB	5,281,927	01/94	Parker	/		
	AC	5,576,647	11/96	Sutardja et al.	/		
	AD	5,774,022	06/98	Griffin et al.	/		
	AE	5,516,434	05/95	Kootstra et al.	/		
	AF	5,412,665	05/95	Gruodis et al.	/		
	AG	5,340,968	08/94	Watanabe et al.	/		
	AH	5,907,789	05/99	Komatsu	/		
	AI	5,780,916	07/98	Berger et al.	/		
	AJ	3,924,320	12/75	Altman et al.	/		
<div style="font-size: 2em; font-family: cursive;">S</div>	AK	6,130,602	10/00	O'Toole et al.	/		
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
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	AL						
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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	AR						
EXAMINER <div style="font-family: cursive; font-size: 1.2em;">Eden C. Holden</div>				DATE CONSIDERED <div style="font-size: 1.5em;">3-19-04</div>			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M140-325SERIAL NO.
09/822,063

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT
James E. O'Toole et al.FILING DATE
March 30, 2001GROUP
2635

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
EA	AA	5,640,151	06/17/97	Reis et al.	340	825.54	
	AB	4,384,288	05/17/83	Walton	340	825.34	
	AC	4,514,731	04/30/85	Falck et al.	340	825.08	
	AD	4,868,908	09/19/89	Pless et al.	323	267	
	AE	5,103,156	04/07/92	Jones et al.	320	35	
	AF	5,406,297	04/11/95	Caswell et al.	343	741	
EA	AG	5,485,520	01/16/96	Chaum et al.	380	24	
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

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3-19-04

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Form PTO-1449

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PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
M140-325

SERIAL NO.
09/822,063

APPLICANT
James E. O'Toole et al.

FILING DATE
March 30, 2001

GROUP
2635

LIST OF ART CITATIONS BY APPLICANT
(Use separate sheets if necessary)

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
EA	AA	5,361,403	11/1994	Dent	455	74	
	AB	5,423,074	06/1995	Dent	455	74	
	AC	4,783,646	11/1988	Matsuzaki	340	572	
	AD	5,072,194	12/1991	Chevallier	330	260	
	AE	5,300,896	04/1994	Suesserman	330	260	
	AF	5,365,192	11/1994	Wagner et al.	330	260	
	AG	5,394,159	02/1995	Schneider et al.	343	700	
	AH	4,190,838	02/1980	Kemp	375	205	
SA	AI	5,511,090	04/1996	Denton et al.	375	205	
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
EA	AL	0 172 445 A1	07/1985	EPO				x
	AM	0 682 382 A2	04/1995	EPO			x	
	AN	0 682 382 A3	05/1995	EPO			x	
	AO	DE 3212876 A1	04/1983	Germany				x
SA	AP	0 616 429 A1	01/1994	EPO				x

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

SA	AR	N.J. Woods et al., "One micrometre scale self-aligned cobalt disilicide Schottky barrier diodes", ELECTRONICS LETTERS, IEE Stevenage, GB,
		Vol. 31, No. 21, Oct. 1995, pages 1878-1880
SA	AS	Shenai Krishna, "Characteristics of LPCVD WS12/N-Si Schottky Contacts", IEEE ELECTRON DEVICE LETTERS, US, IEEE INC. N.Y., Vol. 12
		No. 4, April 1991, pages 169-171
	AT	

EXAMINER *Eden C. H. Lee* DATE CONSIDERED 3-19-04

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APPLICANT
Micron Technology, Inc.

FILING DATE
March 30, 2001

GROUP
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U.S. PATENT DOCUMENTS

Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
SA	AA	5,780,916	7/98	Berger et al.	257	471	
SA	AB	5,143,820	09/92	Kotecha et al.	430	314	
SA	AC	4,478,881	10/84	Bartur et al.	427	90	
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

SA	AR		Fink & Christiansen, ELECTRONIC ENGINEER'S HANDBOOK, 3rd Edition, McGraw-Hill, 1989, pgs. 8-22, 8-23 and 8-40.
SA	AS		Wolf, SILICON PROCESSING FOR THE VLSI ERA VOLUME 2: PROCESS INTEGRATION, 1986, Lattice Press, pgs. 65 and 195.
	AT		

EXAMINER

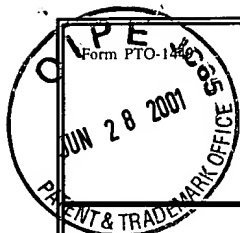
Ed C. Allen

DATE CONSIDERED

3-19-04

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Form PTO-144

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SERIAL NO.
09/822,063

LIST OF ART CITED BY APPLICANT
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APPLICANT
Micron Technology, Inc.

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U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AR		E.C. Young, "The Penguin Dictionary of Electronics", 1988, Market House Books, pages 7 and 124.
	AS		
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Sheet 1 of 1

Form PTO-1449

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PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M140-325SERIAL NO.
09/822,063LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
Micron Technology, Inc.FILING DATE
March 30, 2001GROUP
2635

U.S. PATENT DOCUMENTS

Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
SA	AA	5,780,916	7/98	Berger et al.	257	471	
SA	AB	5,143,820	09/92	Kotecha et al.	430	314	
SA	AC	4,478,881	10/84	Bartur et al.	427	90	
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

SA	AR		Fink & Christiansen, ELECTRONIC ENGINEER'S HANDBOOK, 3rd Edition, McGraw-Hill, 1989, pgs. 8-22, 8-23 and 8-40.
SA	AS		Wolf, SILICON PROCESSING FOR THE VLSI ERA VOLUME 2: PROCESS INTEGRATION, 1986, Lattice Press, pgs. 65 and 195.
	AT		

EXAMINER

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI40-325		SERIAL NO. 09/822,063	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT James E. O'Toole et al.			
				FILING DATE March 30, 2001		GROUP 2635	
U.S. PATENT DOCUMENTS							
Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
EA	AA	5,446,765	08/29/95	Leger	375	359	
	AB	5,668,560	09/16/97	Evans et al.	343	702	
	AC	5,970,398	10/19/99	Tuttle	455	193.1	
	AD	6,122,494	9/19/00	Tuttle	455	193.1	
	AE	4,897,662	01/30/90	Lee et al.	343	701	
	AF	4,942,393	07/17/90	Waraksa et al.	340	825.72	
	AG	5,235,326	08/10/93	Beigel et al.	340	825.54	
	AH	5,317,309	05/31/94	Vercellotti et al.	340	825.54	
	AI	5,519,386	05/21/96	Tobergte	340	825.54	
	AJ	5,649,295	07/15/97	Shober et al.	455	38.2	
	AK	5,940,006	08/17/99	MacLellan et al.	340	825.54	
	AL	6,249,212 B1	06/19/01	Beigel et al.	340	10.34	
	AM	5,491,718	02/13/96	Gould et al.	375	205	
EA	AN	5,606,322	02/25/97	Allen et al.	341	173	
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
EA	AO	2 238 210 A	05/1991	GB			x
	AP						
	AQ						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
EA	AR		J. Buechler, et al., "Silicon Millimeter - Wave Circuits for Receivers and Transmitters", IEEE Microwaves & Millimeter-Wave Monolithic etc. Symp. pp. 67-70 (1988)				
	AS						
EXAMINER				DATE CONSIDERED			
Ed C. Hollis				3-19-04			
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